


<b>Search Notes</b> 	<b>Application/Control No.</b> 10675240	<b>Applicant(s)/Patent Under Reexamination</b> MALTSEV ET AL.
	<b>Examiner</b> Flores, Leon	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	260, 340, 343, 354, 355, 371	5/2/2007	LF
455	516	5/2/2007	LF
370	206, 503	5/2/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	5/3/2007	LF
Search in NPL (IEEE)	5/2/2007	LF
Checked for double patenting.	5/2/2007	LF
Consulted with SPE David Payne in regards to the amendment.	9/11/2007	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	260, 354, 340, 371	9/10/2007	LF
370	206, 210	9/10/2007	LF
455	516	9/10/2007	LF